EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	4	(((determin$4 same nonuniformity (imperfection or anomalit$4 or defects)) same (patterns same regularity)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:16
L2	0	((((determin$4 near nonuniformity) same (imperfection or anomalit$4 or defects)) same (patterns same regularity)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:16
L3	0	((((determin$4 near nonuniformity) and (imperfection or anomalit$4 or defects)) same (patterns same regularity)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:16
L4	0	((((determin$4 near nonuniformity) and (imperfection or anomalit$4 or defects)) same (patterns same regularity))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:16
L5	0	((((determin$4 same nonuniformity) and (imperfection or anomalit$4 or defects)) same (patterns same regularity))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:17
L6	1	((((examin$5 or analy$4 or measur$4 or determin$4) near (nonuniformity near defects)) same (photomask or pattern) same (image near device))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:18
L7	1	((((examin$5 or analy$4 or measur$4 or determin$4) near (nonuniformity near defects)) same (photomask or pattern) same (image near device)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:18
L8	1	((((examin$5 or analy$4 or measur$4 or determin$4) same (nonuniformity near defects)) same (photomask or pattern) same (image near device))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:19

L11	1	((((examin$5 or analy$4 or measur$4 or determin$4) same (nonuniformity same (defects or imperfection$1 or pattern))) same (photomask or pattern) same (image near device))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:21
L12	517	((((examin$5 or analy$4 or measur$4 or determin$4) same (nonuniformity same (defects or imperfection$1 or pattern))) same (photomask or pattern or mask))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:21
L13	13	((((examin$5 or analy$4 or measur$4 or determin$4) same (nonuniformity same (defects or imperfection$1 or pattern))) same (photomask or pattern or mask)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:21
L14	0	((((examin$5 or analy$4 or measur$4 or determin$4) near (nonuniformity same (defects or imperfection$1 or pattern))) near (photomask or pattern or mask)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:22
L15	0	((((examin$5 or analy$4 or measur$4 or determin$4) near (nonuniformity same (defects or imperfection$1 or pattern))) near (photomask or pattern or mask))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:22
L16	5	((((examin$5 or analy$4 or measur$4 or determin$4) near (nonuniformity same (defects or imperfection$1 or pattern))) same (photomask or pattern or mask))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:24
L17	4	12 and (("500" near (nm or nanometer)) and (visible near (light or wavelength)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:25
L18	0	13 and (("500" near (nm or nanometer)) and (visible near (light or wavelength)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:25

L19	2	12 and (("500" near (nm or nanometer)) and (visible near (light or wavelength))) and diffract$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/09 15:25
L20	0	("2007/0121106").URPN.	USPAT	OR	ON	2009/04/09 15:26
S1	1	"10575378"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 09:26
S2	310	356/237.2-237.6.ccls. and (pattern same (defect$4 or nonuniformity or defromation) and (photo near mask or (photomask)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 10:41
S3	5587	(pattern same (defect$4 or nonuniformity or defromation) and (photo near mask or (photomask)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 10:41
S4	2305	356/237.2-237.6.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 10:41
S5	46	S2 and (manufactur$4 and wavelength and detect$4 and extract$4 and repeat $4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 11:17
S6	241	S3 and (manufactur$4 and wavelength and detect$4 and extract$4 and repeat $4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 11:17
S7	146	S4 and (manufactur$4 and wavelength and detect$4 and extract$4 and repeat $4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 11:17

S8	0	S6 and ((wafer or substrate) same (transpartent))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 11:47
S9	0	S5 and ((wafer or substrate) same (transpartent))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 11:47
S10	0	S7 and ((wafer or substrate) same (transpartent))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 11:47
S11	53	S7 and ((wafer or substrate) same (transparent))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 11:47
S12	92	S6 and ((wafer or substrate) same (transparent))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 11:47
S13	16	S5 and ((wafer or substrate) same (transparent))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 11:47
S14	750	(tanaka near junichi)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 12:24
S15	898	(yamaguchi near noboru)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 12:24
S16	3	S14 and (pattern same (defect$4 or nonuniformity or defromation) and (photo near mask or (photomask)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 12:24

S17	6	S15 and (pattern same (defect$4 or nonuniformity or defromation) and (photo near mask or (photomask)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 12:24
S18	2	Ishikawa near Yuudai	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:48
S19	467	Hara near Atsushi	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:48
S20	1834	Kobayashi near Masaaki	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:50
S21	2	S20 and (pattern and (defect$4 or nonuniformity or defromation) and (photo near mask or (photomask)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:50
S22	1	S19 and (pattern and (defect$4 or nonuniformity or defromation) and (photo near mask or (photomask)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:50
S23	0	("2005/0220330").URPN.	USPAT	OR	OFF	2008/02/11 14:51
S24	0	S20 and (manufactur$4 and wavelength and detect$4 and extract$4 and repeat $4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:52
S25	0	S19 and (manufactur$4 and wavelength and detect$4 and extract$4 and repeat $4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:52

S26	277	382/141,144,145.ccls. and (pattern same (defect$4 or nonuniformity or defromation) and (photo near mask or (photomask)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:57
S27	100	S26 and (sensitivity same detect$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:58
S28	8	S20 and (sensitivity same detect$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/11 14:58
S29	1834	Kobayashi near Masaaki	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 07:47
S30	8	S29 and (sensitivity same detect$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 07:47
S31	15	(US-20070070338-$ or US-20050110988-$ or US-20050110987-$ or US-20060012780-$ or US-20060158642-$ or US-20010021015-$).did. or (US-5436464-$ or US-5486919-$ or US-5629768-$ or US-6774987-$ or US-6943876-$ or US-7180586-$ or US-5963314-$ or US-6411377-$ or US-6438438-$).did.	US-PGPUB; USPAT	OR	OFF	2008/02/12 09:16
S32	7	S31 and (((extract$4 or select$4) same (wavelength or light or band)) and (pattern near (defect$4 or deformation)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 09:19
S33	1992	(((extract$4 or select$4) same (wavelength or light or band)) and (pattern near (defect$4 or deformation)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 09:19

S34	0	S32 and (sensitiv$4 and photmask)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 09:28
S35	2	S33 and (sensitiv$4 and photmask)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 09:28
S36	59	250/559.42,559.44-559.45. ccls. and (((extract$4 or select$4) same (wavelength or light or band)) and (pattern near (defect$4 or deformation)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 10:53
S37	5	S36 and (filter near (wavelength or beam or plurality or select$4 or extract$4 or direct$4 or light))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 11:36
S38	263	S33 and (filter near (wavelength or beam or plurality or select$4 or extract$4 or direct$4 or light))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 11:36
S39	9	S29 and (filter near (wavelength or beam or plurality or select$4 or extract$4 or direct$4 or light))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 11:36
S40	5	S36 and (filter near (select $4 or extract$4 or light or beam or wavelength or band or direct$4))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 13:52
S41	4	S36 and (filter near (select $4 or light or beam or wavelength or band or direct $4))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/12 13:53
S42	5	("5777729" | "6097483" | "6288780").PN. OR ("6654113").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/02/12 14:00

S43	0	((photodetect$4 near (signal or output or data)) same (determin$4 near nonuniformity (imperfection or anomalit$4 or defects)) same (patterns same regularity)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/01/29 14:15
S44	0	((photodetect$4 near (signal or output or data)) same (determin$4 same nonuniformity (imperfection or anomalit$4 or defects)) same (patterns same regularity)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/01/29 15:23
S45	1	((photodetect$4 near (signal or output or data)) same (determin$4 same nonuniformity (imperfection or anomalit$4 or defects)) same (patterns same regularity))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/01/29 15:23
S46	181	((determin$4 same nonuniformity (imperfection or anomalit$4 or defects)) same (patterns same regularity))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/01/29 15:23
S47	4	((determin$4 same nonuniformity (imperfection or anomalit$4 or defects)) same (patterns same regularity)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/01/29 15:23
S48	0	((wavelength near ("500" or "600" or visible)) near patterns) same (diffraction same (edge same pattern)) and (convert$4 same light same data).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/08 14:24
S49	0	((wavelength near ("500" or "600" or visible)) near patterns) same (diffraction same (edge same pattern)) and (convert$4 same light same data)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/08 14:25
S50	2	"6208750".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/08 14:31

S51	2	"5781657".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/08 14:31
S52	2	"5572598".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/04/08 14:31
S53	14	("4731855" | "5072128" | "5539514" | "5699447").PN. OR ("6208750").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2009/04/08 14:42

4/9/2009 3:26:20 PM
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